

INTERNATIONAL STANDARD

**3D displays –
Part 62-12: Measurement methods for virtual-image type – Image quality**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

3D DISPLAYS –

Part 62-12: Measurement methods for virtual-image type – Image quality

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The text of this International Standard is based on the following documents:

Draft	Report on voting
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Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.